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What is "Embedded - Microcontrollers"?

"Embedded - Microcontrollers" refer to small, integrated circuits designed to perform specific tasks within larger systems. These microcontrollers are essentially compact computers on a single chip, containing a processor core, memory, and programmable input/output peripherals. They are called "embedded" because they are embedded within electronic devices to control various functions, rather than serving as standalone computers. Microcontrollers are crucial in modern electronics, providing the intelligence and control needed for a wide range of applications.

Applications of "Embedded - Microcontrollers"

Details	
Product Status	Active
Core Processor	ARM® Cortex®-M4
Core Size	32-Bit Single-Core
Speed	168MHz
Connectivity	CANbus, I²C, SPI, UART/USART
Peripherals	DMA, LVD, POR, PWM, WDT
Number of I/O	74
Program Memory Size	128KB (128K x 8)
Program Memory Type	FLASH
EEPROM Size	-
RAM Size	24K x 8
Voltage - Supply (Vcc/Vdd)	1.71V ~ 3.6V
Data Converters	A/D 38x12b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 105°C (TA)
Mounting Type	Surface Mount
Package / Case	100-LQFP
Supplier Device Package	100-LQFP (14x14)
Purchase URL	https://www.e-xfl.com/product-detail/nxp-semiconductors/mkv42f128vll16

Kinetis Motor Suite

- Supports velocity and position control of BLDC and PMSM motors
- Implements Field Orient Control (FOC) using Back EMF to improve motor efficiency
- Utilizes SpinTAC control theory that improves overall system performance and reliability

Security and integrity modules

- Hardware CRC module to support fast cyclic redundancy checks
- External Watchdog Monitor (EWM)

NOTE

The 48-pin LQFP package for this product is not yet available. However, it is included in a Package Your Way program for Kinetis MCUs. Visit nxp.com/KPYW for more details.

Orderable part numbers summary[1]

NXP part number	CPU frequency (MHz)	Pin count	Total flash memory (KB)	SRAM (KB)	ADC		eFlexPWM		PWM Nano-Edge	Flex Timers			DAC	FlexCAN	
					ADCA	ADCB	PWMA PWMB	PWMX		FTM0	FTM3	FTM1		CAN0	CAN1
MKV46F256VLL16	168	100	256	32	18ch	20ch	1x8ch	1x4ch	Yes	1x8ch	1x8ch	1x2ch	1	1	1
MKV46F256VLH16	168	64	256	32	13ch	16ch	1x8ch	—	Yes	1x8ch	1x8ch	1x2ch	1	1	1
MKV46F128VLL16	168	100	128	24	18ch	20ch	1x8ch	1x4ch	Yes	1x8ch	1x8ch	1x2ch	1	1	1
MKV46F128VLH16	168	64	128	24	13ch	16ch	1x8ch	—	Yes	1x8ch	1x8ch	1x2ch	1	1	1
MKV44F256VLL16	168	100	256	32	18ch	20ch	1x8ch	1x4ch	Yes	—	—	—	1	1	1
MKV44F256VLH16	168	64	256	32	13ch	16ch	1x8ch	—	Yes	—	—	—	1	1	1
MKV44F128VLL16	168	100	128	24	18ch	20ch	1x8ch	1x4ch	Yes	—	—	—	1	1	1
MKV44F128VLH16	168	64	128	24	13ch	16ch	1x8ch	—	Yes	—	—	—	1	1	1
MKV44F128VLF16[2]	168	48	128	24	11ch	10ch	1x8ch	—	Yes	—	—	—	1	1	—
MKV44F64VLH16	168	64	64	16	13ch	16ch	1x8ch	—	Yes	—	—	—	1	1	1
MKV44F64VLF16[2]	168	48	64	16	11ch	10ch	1x8ch	—	Yes	—	—	—	1	1	—
MKV42F256VLL16	168	100	256	32	18ch	20ch	—	—	—	1x8ch	1x8ch	1x2ch	—	1	1
MKV42F256VLH16	168	64	256	32	13ch	16ch	—	—	—	1x8ch	1x8ch	1x2ch	—	1	1
MKV42F128VLL16	168	100	128	24	18ch	20ch	—	—	—	1x8ch	1x8ch	1x2ch	—	1	1

Table continues on the next page...

Orderable part numbers summary[1] (continued)

NXP part number	CPU frequency (MHz)	Pin count	Total flash memory (KB)	SRAM (KB)	ADC		eFlexPWM		PWM Nano-Edge	Flex Timers			DAC	FlexCAN	
					ADCA	ADCB	PWMA PWMB	PWMX		FTM0	FTM3	FTM1		CAN0	CAN1
MKV42F128VLH16	168	64	128	24	13ch	16ch	—	—	—	1x8ch	1x8ch	1x2ch	—	1	1
MKV42F128VLF16[2]	168	48	128	24	11ch	10ch	—	—	—	1x8ch	1x8ch	1x2ch	—	1	—
MKV42F64VLH16	168	64	64	16	13ch	16ch	—	—	—	1x8ch	1x8ch	1x2ch	—	1	1
MKV42F64VLF16[2]	168	48	64	16	11ch	10ch	—	—	—	1x8ch	1x8ch	1x2ch	—	1	—

1. To confirm current availability of ordererable part numbers, go to http://www.nxp.com and perform a part number search.
2. Package Your Way.

Related Resources

Type	Description	Resource
Selector Guide	The Solution Advisor is a web-based tool that features interactive application wizards and a dynamic product selector.	Solution Advisor
Reference Manual	The Reference Manual contains a comprehensive description of the structure and function (operation) of a device.	KV4XP100M168RM[1]
Data Sheet	The Data Sheet includes electrical characteristics and signal connections.	KV4XP100M168[1]
Chip Errata	The chip mask set Errata provides additional or corrective information for a particular device mask set.	Kinetis_V_1N72K[1]
KMS User Guide	The KMS User Guide provides a comprehensive description of the features and functions of the Kinetis Motor Suite solution.	Kinetis Motor Suite User's Guide (KMS100UG)[1]
KMS API Reference Manual	The KMS API reference manual provides a comprehensive description of the API of the Kinetis Motor Suite function blocks.	Kinetis Motor Suite API Reference Manual (KMS100RM)[1]
Package drawing	Package dimensions are provided in package drawings.	• LQFP 100-pin: 98ASS23308W[1] • LQFP 64-pin: 98ASS23234W[1] • LQFP 48-pin: 98ASH00962A[1]

1. To find the associated resource, go to http://www.nxp.com and perform a search using this term.

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Symbol	Description	Min.	Max.	Unit
V_{DD}	Digital supply voltage	–0.3	3.8	V
I_{DD}	Digital supply current	—	120	mA
V_{IO}	Digital pin input voltage (except open drain pins)	–0.3	VDD + 0.3[1]	V
	Open drain pins (PTC6 and PTC7)	–0.3	5.5	V
I_D	Instantaneous maximum current single pin limit (applies to all port pins)	–25	25	mA
V_{DDA}	Analog supply voltage	V_{DD} – 0.3	V_{DD} + 0.3	V

1. Maximum value of V_{IO} (except open drain pins) must be 3.8 V.

1.5 Absolute Maximum Ratings

Absolute maximum ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond the limits specified in Table 1 may affect device reliability or cause permanent damage to the device. For functional operating conditions, refer to the remaining tables in this section.

Table 1. Absolute Maximum Ratings (V_{SS} = 0 V, V_{SSA} = 0 V)

Symbol	Description	Notes[1]	Min	Max	Unit
V_{DD}	Supply Voltage Range		-0.3	4.0	V
V_{DDA}	Analog Supply Voltage Range		-0.3	4.0	V
V_{REFHx}	ADC High Voltage Reference		-0.3	4.0	V
V_{REFLx}	ADC Low Voltage Reference		-0.3	0.3	V
ΔV_{DD}	Voltage difference V_{DD} to V_{DDA}		-0.3	0.3	V
ΔV_{SS}	Voltage difference V_{SS} to V_{SSA}		-0.3	0.3	V
V_{IN}	Digital Input Voltage Range	Pin Groups 1, 2	-0.3	4.0	V
V_{OSC}	Oscillator Input Voltage Range	Pin Group 4	-0.4	4.0	V
V_{INA}	Analog Input Voltage Range	Pin Group 3	-0.3	4.0	V
I_{IC}	Input clamp current, per pin (V_{IN} < 0)		—	-20.0	mA
I_{OC}	Output clamp current, per pin (V_O < 0)[2]		—	-20.0	mA
V_{OUT}	Output Voltage Range (Normal Push-Pull mode)	Pin Group 1	-0.3	4.0	V
V_{OUTOD}	Output Voltage Range (Open Drain mode)	Pin Group 2	-0.3	5.5	V
V_{OUT_DAC}	DAC Output Voltage Range	Pin Group 5	-0.3	4.0	V
T_A	Ambient Temperature Industrial		-40	105	°C
T_{STG}	Storage Temperature Range (Extended Industrial)		-55	150	°C

1. Default Mode
   - Pin Group 1: GPIO, TDI, TDO, TMS, TCK
   - Pin Group 2: $\overline{\text{RESET}}$, PORTC6, and PORTC7
   - Pin Group 3: ADC and Comparator Analog Inputs

All digital I/O switching characteristics, unless otherwise specified, assume:

1. output pins
   - have C_L=30pF loads,
   - are slew rate disabled, and
   - are normal drive strength

2.2 Nonswitching electrical specifications

2.2.1 Recommended Operating Conditions

This section includes information about recommended operating conditions.

NOTE

Recommended V_{DD} ramp rate is between 1 ms and 200 ms.

Table 2. Recommended Operating Conditions (V_{REFLx}=0V, V_{SSA}=0V, V_{SS}=0V)

Symbol	Description	Notes[1]	Min	Typ	Max	Unit
V_{DD}	Supply Voltage Digital	2, 3	1.71		3.6	V
V_{DDA}	Supply voltage (analog)	2, 3	2.7	3.0	3.6	V
V_{REFHx}	ADC (Cyclic) Reference Voltage High		2.7		V_{DDA}	V
ΔVDD	Voltage difference V_{DD} to V_{DDA}		-0.1	0	0.1	V
ΔVSS	Voltage difference V_{SS} to V_{SSA}		-0.1	0	0.1	V
F_MCGOUT	Device Clock Frequency • using internal RC oscillator • using external clock source		0.04 0		168 168	MHz
V_{IH}	Input Voltage High (digital inputs)	Pin Groups 1, 2	0.7 x V_{DD}		3.6	V
V_{IL}	Input Voltage Low (digital inputs)	Pin Groups 1, 2			0.35 x V_{DD}	V
V_{IHOSC}	Oscillator Input Voltage High XTAL driven by an external clock source	Pin Group 4	2.0		V_{DD} + 0.3	V
V_{ILOSC}	Oscillator Input Voltage Low	Pin Group 4	-0.3		0.8	V
C_{out}	DAC Output Current Drive Strength	Pin Group 5			1	mA
T_A	Ambient Operating Temperature		-40		105	°C

1. Default Mode
   - Pin Group 1: GPIO, TDI, TDO, TMS, TCK
   - Pin Group 2: $\overline{\text{RESET}}$
   - Pin Group 3: ADC and Comparator Analog Inputs
   - Pin Group 4: XTAL, EXTAL
   - Pin Group 5: DAC analog output
   - Pin Group 6: PTB0, PTB1, PTD4, PTD5, PTD6, PTD7, PTC3, and PTC4. have high output current capability
   - Pin Group 7: PTC6 and PTC7 are true open drain pins and have no P-chanl transistor. A external pull-up resistor is required when these pins are outputs.

Table 6. Power consumption operating behaviors (All IDDs are Target values) (continued)

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
	• @ –40 to 25°C	—	2.7	3.3	µA	
	• @ 70°C	—	6.6	12.2	µA	
	• @ 105°C	—	25.9	50.5	µA	
I_{DD_VLLS1}	Very low-leakage stop mode 1 current at 3.0 V					
	• @ –40 to 25°C	—	740	1200	nA	
	• @ 70°C	—	2.5	10.6	µA	
	• @ 105°C	—	11.1	26.5	µA	
I_{DD_VLLS0B}	Very low-leakage stop mode 0 current at 3.0 V with POR detect circuit enabled					
	• @ –40 to 25°C	—	420	832	nA	
	• @ 70°C	—	1.9	9.4	µA	
	• @ 105°C	—	10.8	26.3	µA	
I_{DD_VLLS0A}	Very low-leakage stop mode 0 current at 3.0 V with POR detect circuit disabled					
	• @ –40 to 25°C	—	200	599	nA	
	• @ 70°C	—	1.8	10.5	µA	
	• @ 105°C	—	10.8	26.3	µA	

Table 7. Low power mode peripheral adders — typical value

Symbol	Description	Temperature (°C)						Unit
		-40	25	50	70	85	105	
$I_{IREFSTEN4MHz}$	4 MHz internal reference clock (IRC) adder. Measured by entering STOP or VLPS mode with 4 MHz IRC enabled.	56	56	56	56	56	56	µA
$I_{IREFSTEN32KHz}$	32 kHz internal reference clock (IRC) adder. Measured by entering STOP mode with the 32 kHz IRC enabled.	52	52	52	52	52	52	µA
$I_{EREFSTEN4MHz}$	External 4 MHz crystal clock adder. Measured by entering STOP or VLPS mode with the crystal enabled.	206	228	237	245	251	258	uA
$I_{EREFSTEN32KHz}$	External 32 kHz crystal clock adder by means of the OSC0_CR[EREFSTEN and EREFSTEN] bits. Measured by entering all modes with the crystal enabled.							nA
	VLLS1							
	VLLS3	440	490	540	560	570	580	
	VLPS	440	490	540	560	570	580	
	STOP	510	560	560	560	610	680	

Table continues on the next page...

1. The greater synchronous and asynchronous timing must be met.
2. This is the shortest pulse that is guaranteed to be recognized.
3. For high drive pins with high drive enabled, load is 75pF; other pins load (low drive) is 25pF.

2.4 Thermal specifications

2.4.1 Thermal operating requirements

Table 12. Thermal operating requirements

Symbol	Description	Min.	Max.	Unit
T_J	Die junction temperature	–40	125	°C
T_A	Ambient temperature	–40	105	°C

2.4.2 Thermal attributes

Table 13. Thermal attributes

Board type	Symbol	Description	100 LQFP	64 LQFP	48 LQFP	Unit	Notes
Single-layer (1S)	$R_{\theta JA}$	Thermal resistance, junction to ambient (natural convection)	62	64	71	°C/W	1
Four-layer (2s2p)	$R_{\theta JA}$	Thermal resistance, junction to ambient (natural convection)	49	46	47	°C/W	
Single-layer (1S)	$R_{\theta JMA}$	Thermal resistance, junction to ambient (200 ft./min. air speed)	52	52	58	°C/W	
Four-layer (2s2p)	$R_{\theta JMA}$	Thermal resistance, junction to ambient (200 ft./min. air speed)	43	39	41	°C/W	
—	$R_{\theta JB}$	Thermal resistance, junction to board	35	28	24	°C/W	2
—	$R_{\theta JC}$	Thermal resistance, junction to case	17	15	18	°C/W	3
—	Ψ_{JT}	Thermal characterization parameter, junction to package top outside center (natural convection)	3	2	2	°C/W	4

1. Determined according to JEDEC Standard JESD51-2, *Integrated Circuits Thermal Test Method Environmental Conditions—Natural Convection (Still Air)*, or EIA/JEDEC Standard JESD51-6, *Integrated Circuit Thermal Test Method Environmental Conditions—Forced Convection (Moving Air)*.
2. Determined according to JEDEC Standard JESD51-8, *Integrated Circuit Thermal Test Method Environmental Conditions—Junction-to-Board*.
3. Determined according to Method 1012.1 of MIL-STD 883, *Test Method Standard, Microcircuits*, with the cold plate temperature used for the case temperature. The value includes the thermal resistance of the interface material between the top of the package and the cold plate.

4. Determined according to JEDEC Standard JESD51-2, *Integrated Circuits Thermal Test Method Environmental Conditions—Natural Convection (Still Air)*.

3 Peripheral operating requirements and behaviors

3.1 Core modules

3.1.1 SWD Electricals

Table 14. SWD full voltage range electricals

Symbol	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
J1	SWD_CLK frequency of operation • Serial wire debug	 0	 25	 MHz
J2	SWD_CLK cycle period	1/J1	—	ns
J3	SWD_CLK clock pulse width • Serial wire debug	 20	 —	 ns
J4	SWD_CLK rise and fall times	—	3	ns
J9	SWD_DIO input data setup time to SWD_CLK rise	10	—	ns
J10	SWD_DIO input data hold time after SWD_CLK rise	0	—	ns
J11	SWD_CLK high to SWD_DIO data valid	—	32	ns
J12	SWD_CLK high to SWD_DIO high-Z	5	—	ns

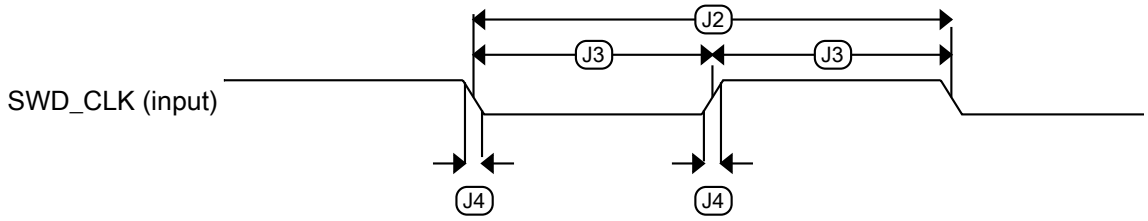

Figure 5. Serial wire clock input timing

Table 16. JTAG limited voltage range electricals (continued)

Symbol	Description	Min.	Max.	Unit
J11	TCLK low to TDO data valid	—	19	ns
J12	TCLK low to TDO high-Z	—	17	ns
J13	$\overline{\text{TRST}}$ assert time	100	—	ns
J14	$\overline{\text{TRST}}$ setup time (negation) to TCLK high	8	—	ns

Table 17. JTAG full voltage range electricals

Symbol	Description	Min.	Max.	Unit
	Operating voltage	1.71	3.6	V
J1	TCLK frequency of operation			MHz
	• Boundary Scan	0	10	
	• JTAG and CJTAG	0	20	
	• Serial Wire Debug	0	40	
J2	TCLK cycle period	1/J1	—	ns
J3	TCLK clock pulse width			
	• Boundary Scan	50	—	ns
	• JTAG and CJTAG	25	—	ns
	• Serial Wire Debug	12.5	—	ns
J4	TCLK rise and fall times	—	3	ns
J5	Boundary scan input data setup time to TCLK rise	20	—	ns
J6	Boundary scan input data hold time after TCLK rise	2.0	—	ns
J7	TCLK low to boundary scan output data valid	—	30.6	ns
J8	TCLK low to boundary scan output high-Z	—	25	ns
J9	TMS, TDI input data setup time to TCLK rise	8	—	ns
J10	TMS, TDI input data hold time after TCLK rise	1.0	—	ns
J11	TCLK low to TDO data valid	—	19.0	ns
J12	TCLK low to TDO high-Z	—	17.0	ns
J13	$\overline{\text{TRST}}$ assert time	100	—	ns
J14	$\overline{\text{TRST}}$ setup time (negation) to TCLK high	8	—	ns

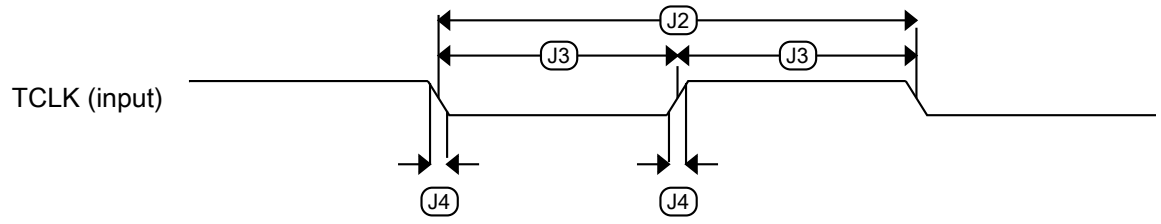

Figure 9. Test clock input timing

Table 19. Oscillator DC electrical specifications (continued)

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
	• 8 MHz	—	500	—	µA	
	• 16 MHz	—	2.5	—	mA	
	• 24 MHz	—	3	—	mA	
	• 32 MHz	—	4	—	mA	
C_x	EXTAL load capacitance	—	—	—		2, 3
C_y	XTAL load capacitance	—	—	—		2, 3
R_F	Feedback resistor — low-frequency, low-power mode (HGO=0)	—	—	—	MΩ	2, 4
	Feedback resistor — low-frequency, high-gain mode (HGO=1)	—	10	—	MΩ	
	Feedback resistor — high-frequency, low-power mode (HGO=0)	—	—	—	MΩ	
	Feedback resistor — high-frequency, high-gain mode (HGO=1)	—	1	—	MΩ	
R_S	Series resistor — low-frequency, low-power mode (HGO=0)	—	—	—	kΩ	
	Series resistor — low-frequency, high-gain mode (HGO=1)	—	200	—	kΩ	
	Series resistor — high-frequency, low-power mode (HGO=0)	—	—	—	kΩ	
	Series resistor — high-frequency, high-gain mode (HGO=1)	—	0	—	kΩ	
V_{pp}[5]	Peak-to-peak amplitude of oscillation (oscillator mode) — low-frequency, low-power mode (HGO=0)	—	0.6	—	V	
	Peak-to-peak amplitude of oscillation (oscillator mode) — low-frequency, high-gain mode (HGO=1)	—	V_{DD}	—	V	
	Peak-to-peak amplitude of oscillation (oscillator mode) — high-frequency, low-power mode (HGO=0)	—	0.6	—	V	
	Peak-to-peak amplitude of oscillation (oscillator mode) — high-frequency, high-gain mode (HGO=1)	—	V_{DD}	—	V	

1. V_{DD}=3.3 V, Temperature =25 °C
2. See crystal or resonator manufacturer's recommendation
3. C_x,C_y can be provided by using the integrated capacitors when the low frequency oscillator (RANGE = 00) is used. For all other cases external capacitors must be used.
4. When low power mode is selected, R_F is integrated and must not be attached externally.
5. The EXTAL and XTAL pins should only be connected to required oscillator components and must not be connected to any other devices.

Table 26. Comparator and 6-bit DAC electrical specifications (continued)

Symbol	Description	Min.	Typ.	Max.	Unit
	• CR0[HYSTCTR] = 00	—	5	—	mV
	• CR0[HYSTCTR] = 01	—	10	—	mV
	• CR0[HYSTCTR] = 10	—	20	—	mV
	• CR0[HYSTCTR] = 11	—	30	—	mV
V_{CMPOh}	Output high	V_{DD} – 0.5	—	—	V
V_{CMPOl}	Output low	—	—	0.5	V
t_{DHS}	Propagation delay, high-speed mode (EN = 1, PMODE = 1)	20	50	200	ns
t_{DLS}	Propagation delay, low-speed mode (EN = 1, PMODE = 0)	80	250	600	ns
	Analog comparator initialization delay[2]	—	—	40	µs
I_{DAC6b}	6-bit DAC current adder (enabled)	—	7	—	µA
INL	6-bit DAC integral non-linearity	–0.5	—	0.5	LSB[3]
DNL	6-bit DAC differential non-linearity	–0.3	—	0.3	LSB

1. Typical hysteresis is measured with input voltage range limited to 0.7 to V_{DD} – 0.7 V.
2. Comparator initialization delay is defined as the time between software writes to change control inputs (writes to DACEN, VRSEL, PSEL, MSEL, VOSEL) and the comparator output settling to a stable level.
3. 1 LSB = $V_{reference}$/64

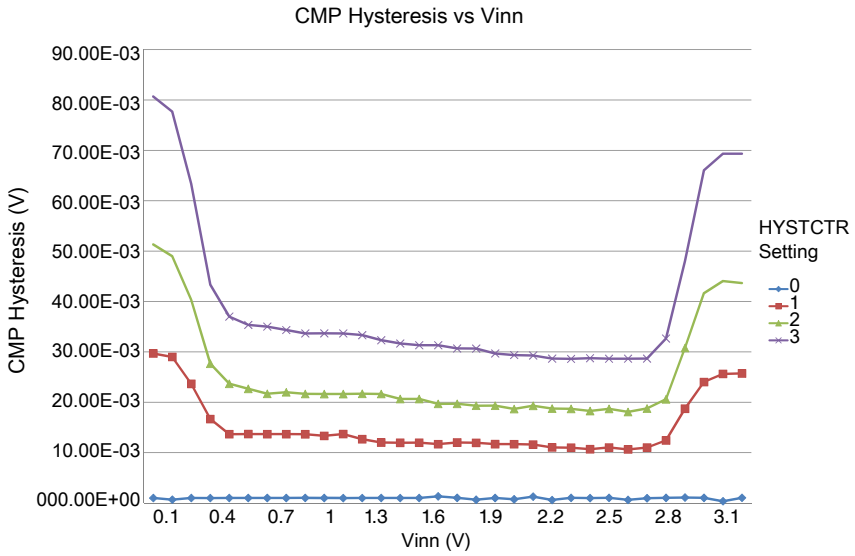

Figure 14. Typical hysteresis vs. Vin level (V_{DD} = 3.3 V, PMODE = 0)

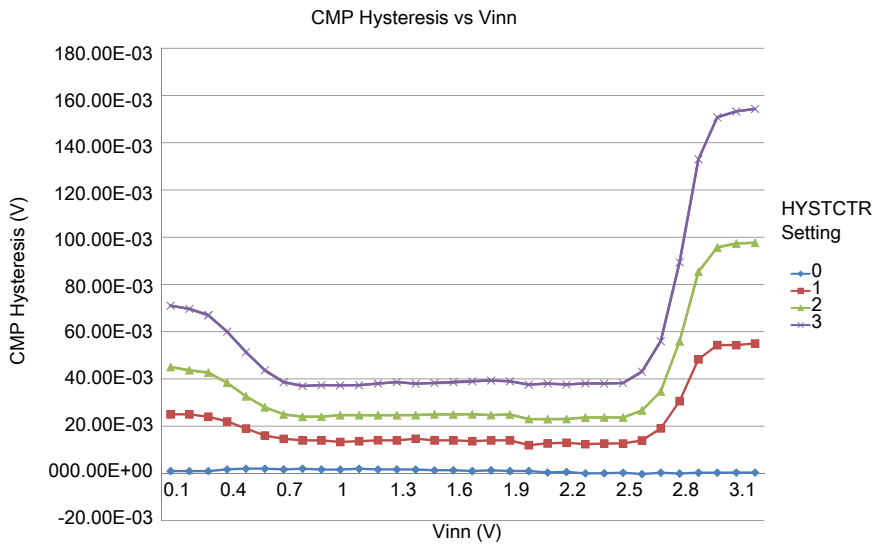

Figure 15. Typical hysteresis vs. Vin level (V_{DD} = 3.3 V, PMODE = 1)

3.6.3 12-bit DAC electrical characteristics

3.6.3.1 12-bit DAC operating requirements

Table 27. 12-bit DAC operating requirements

Symbol	Desciption	Min.	Max.	Unit	Notes
V_{DDA}	Supply voltage	1.71	3.6	V	
V_{DACR}	Reference voltage	1.13	3.6	V	1
C_L	Output load capacitance	—	100	pF	2
I_L	Output load current	—	1	mA	

1. The DAC reference can be selected to be V_{DDA} or V_{REFH}.
2. A small load capacitance (47 pF) can improve the bandwidth performance of the DAC.

3.6.3.2 12-bit DAC operating behaviors

Table 28. 12-bit DAC operating behaviors

Symbol	Description	Min.	Typ.	Max.	Unit	Notes
I_{DDA_DACLP}	Supply current — low-power mode	—	—	330	µA	
I_{DDA_DACHP}	Supply current — high-speed mode	—	—	1200	µA	
t_{DACLP}	Full-scale settling time (0x080 to 0xF7F) — low-power mode	—	100	200	µs	1

Table continues on the next page...

Table 29. NanoEdge PWM timing parameters - 100 Mhz operating frequency (continued)

Characteristic	Symbol	Min.	Typ.	Max.	Unit
Delay for fault input activating to PWM output deactivated		1			ns
Power-up Time[3]	t_{pu}		25		µs

1. Reference 100 MHz in NanoEdge Placement mode.
2. Temperature and voltage variations do not affect NanoEdge Placement step size.
3. Powerdown to NanoEdge mode transition.

Table 30. NanoEdge PWM timing parameters - 84 Mhz operating frequency

Characteristic	Symbol	Min.	Typ.	Max.	Unit
PWM clock frequency			84		MHz
NanoEdge Placement (NEP) Step Size[1], [2]	pwmp		372		ps
Delay for fault input activating to PWM output deactivated		1			ns
Power-up Time[3]	t_{pu}		30		µs

1. Reference 84 MHz in NanoEdge Placement mode.
2. Temperature and voltage variations do not affect NanoEdge Placement step size.
3. Powerdown to NanoEdge mode transition.

3.9 Communication interfaces

3.9.1 SPI (DSPI) switching specifications (limited voltage range)

The DMA Serial Peripheral Interface (DSPI) provides a synchronous serial bus with master and slave operations. Many of the transfer attributes are programmable. The tables below provide DSPI timing characteristics for classic SPI timing modes. Refer to the DSPI chapter of the Reference Manual for information on the modified transfer formats used for communicating with slower peripheral devices.

NOTE

Fast pads:

- SIN: PTE19
- SOUT: PTE18
- SCK: PTE17
- PCS: PTE16

Open drain pads:

Kinetis Motor Suite is a bundled software solution that enables the rapid configuration of motor drive systems, and accelerates development of the final motor drive application.

Several members of the KV4x family are enabled with Kinetis Motor Suite. The enabled devices can be identified within the orderable part numbers in KMS Orderable part numbers summary . For more information,see Kinetis Motor Suite User's Guide (KMS100UG) and Kinetis Motor Suite API Reference Manual (KMS100RM).

NOTE

To find the associated resource, go to http://www.nxp.com and perform a search using the Document ID.

4 Dimensions

4.1 Obtaining package dimensions

Package dimensions are provided in package drawings.

To find a package drawing, go to www.nxp.com and perform a keyword search for the drawing's document number:

If you want the drawing for this package	Then use this document number
48-pin LQFP	98ASH00962A
64-pin LQFP	98ASS23234W
100-pin LQFP	98ASS23308W

5 Pinout

5.1 KV4x Signal Multiplexing and Pin Assignments

The following table shows the signals available on each pin and the locations of these pins on the devices supported by this document. The Port Control Module is responsible for selecting which ALT functionality is available on each pin.

100 LQFP	64 LQFP	48 LQFP	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7
1	1	—	PTE0/ CLKOUT32K	ADCB_CH6f	ADCB_CH6f	PTE0/ CLKOUT32K		UART1_TX	XBAR0_ OUT10	XBAR0_IN11		
2	2	—	PTE1/ LLWU_P0	ADCB_CH7f	ADCB_CH7f	PTE1/ LLWU_P0		UART1_RX	XBAR0_ OUT11	XBAR0_IN7		
3	—	—	PTE2/ LLWU_P1	ADCB_CH6g	ADCB_CH6g	PTE2/ LLWU_P1		UART1_ CTS_b				
4	—	—	PTE3	ADCB_CH7g	ADCB_CH7g	PTE3		UART1_ RTS_b				
5	—	—	PTE4/ LLWU_P2	DISABLED		PTE4/ LLWU_P2						
6	—	—	PTE5	DISABLED		PTE5					FTM3_CH0	
7	—	—	PTE6/ LLWU_P16	DISABLED		PTE6/ LLWU_P16					FTM3_CH1	
8	3	1	VDD	VDD	VDD							
9	4	2	VSS	VSS	VSS							
10	5	3	PTE16	ADCA_CH0	ADCA_CH0	PTE16	SPI0_PCS0	UART1_TX	FTM_CLKIN0		FTM0_FLT3	
11	6	4	PTE17/ LLWU_P19	ADCA_CH1	ADCA_CH1	PTE17/ LLWU_P19	SPI0_SCK	UART1_RX	FTM_CLKIN1		LPTMR0_ ALT3	
12	7	5	PTE18/ LLWU_P20	ADCB_CH0	ADCB_CH0	PTE18/ LLWU_P20	SPI0_SOUT	UART1_ CTS_b	I2C0_SDA			
13	8	6	PTE19	ADCB_CH1	ADCB_CH1	PTE19	SPI0_SIN	UART1_ RTS_b	I2C0_SCL		CMP3_OUT	
14	—	—	ADCA_CH6a	ADCA_CH6a	ADCA_CH6a							
15	—	—	ADCA_CH7a	ADCA_CH7a	ADCA_CH7a							
16	—	7	PTE20	ADCA_CH6b	ADCA_CH6b	PTE20		FTM1_CH0	UART0_TX			
17	—	8	PTE21	ADCA_CH7b	ADCA_CH7b	PTE21		FTM1_CH1	UART0_RX			
18	9	—	ADCA_CH2	ADCA_CH2	ADCA_CH2							
19	10	—	ADCA_CH3	ADCA_CH3	ADCA_CH3							
20	11	—	ADCA_CH6c	ADCA_CH6c	ADCA_CH6c							
21	12	—	ADCA_CH7c	ADCA_CH7c	ADCA_CH7c							
22	13	9	VDDA	VDDA	VDDA							
23	14	10	VREFH	VREFH	VREFH							
24	15	11	VREFL	VREFL	VREFL							
25	16	12	VSSA	VSSA	VSSA							
26	17	13	PTE29	ADCA_CH4/ CMP1_IN5/ CMP0_IN5	ADCA_CH4/ CMP1_IN5/ CMP0_IN5	PTE29		FTM0_CH2		FTM_CLKIN0		
27	18	14	PTE30	DAC0_OUT/ CMP1_IN3/ ADCA_CH5	DAC0_OUT/ CMP1_IN3/ ADCA_CH5	PTE30		FTM0_CH3		FTM_CLKIN1		
28	19	—	ADCA_CH6d/ CMP0_IN4/ CMP2_IN3	ADCA_CH6d/ CMP0_IN4/ CMP2_IN3	ADCA_CH6d/ CMP0_IN4/ CMP2_IN3							
29	—	—	VSS	VSS	VSS							

100 LQFP	64 LQFP	48 LQFP	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7
30	—	—	VDD	VDD	VDD							
31	20	15	PTE24	ADCB_CH4	ADCB_CH4	PTE24	CAN1_TX	FTM0_CH0	XBAR0_IN2	I2C0_SCL	EWM_OUT_b	XBAR0_OUT4
32	21	16	PTE25/ LLWU_P21	ADCB_CH5	ADCB_CH5	PTE25/ LLWU_P21	CAN1_RX	FTM0_CH1	XBAR0_IN3	I2C0_SDA	EWM_IN	XBAR0_OUT5
33	—	—	PTE26	DISABLED		PTE26						
34	22	17	PTA0	JTAG_TCLK/ SWD_CLK		PTA0	UART0_CTS_b/ UART0_COL_b	FTM0_CH5	XBAR0_IN4	EWM_IN		JTAG_TCLK/ SWD_CLK
35	23	18	PTA1	JTAG_TDI		PTA1	UART0_RX	FTM0_CH6	CMP0_OUT		FTM1_CH1	JTAG_TDI
36	24	19	PTA2	JTAG_TDO/ TRACE_SWO		PTA2	UART0_TX	FTM0_CH7	CMP1_OUT		FTM1_CH0	JTAG_TDO/ TRACE_SWO
37	25	20	PTA3	JTAG_TMS/ SWD_DIO		PTA3	UART0_RTS_b	FTM0_CH0	XBAR0_IN9	EWM_OUT_b	FLEXPWMA_A0	JTAG_TMS/ SWD_DIO
38	26	21	PTA4/ LLWU_P3	NMI_b		PTA4/ LLWU_P3		FTM0_CH1	XBAR0_IN10	FTM0_FLT3	FLEXPWMA_B0	NMI_b
39	27	—	PTA5	DISABLED		PTA5		FTM0_CH2		CMP2_OUT		JTAG_TRST_b
40	—	22	VDD	VDD	VDD							
41	—	23	VSS	VSS	VSS							
42	28	—	PTA12	CMP2_IN0	CMP2_IN0	PTA12	CAN0_TX	FTM1_CH0				FTM1_QD_PHA
43	29	—	PTA13/ LLWU_P4	CMP2_IN1	CMP2_IN1	PTA13/ LLWU_P4	CAN0_RX	FTM1_CH1				FTM1_QD_PHB
44	—	—	PTA14	CMP3_IN0	CMP3_IN0	PTA14	SPI0_PCS0	UART0_TX				
45	—	—	PTA15	CMP3_IN1	CMP3_IN1	PTA15	SPI0_SCK	UART0_RX				
46	—	—	PTA16	CMP3_IN2	CMP3_IN2	PTA16	SPI0_SOUT	UART0_CTS_b/ UART0_COL_b				
47	—	—	PTA17	ADCA_CH7e	ADCA_CH7e	PTA17	SPI0_SIN	UART0_RTS_b				
48	30	—	VDD	VDD	VDD							
49	31	—	VSS	VSS	VSS							
50	32	24	PTA18	EXTAL0	EXTAL0	PTA18	XBAR0_IN7	FTM0_FLT2	FTM_CLKIN0	XBAR0_OUT8	FTM3_CH2	
51	33	25	PTA19	XTAL0	XTAL0	PTA19	XBAR0_IN8	FTM1_FLT0	FTM_CLKIN1	XBAR0_OUT9	LPTMR0_ALT1	
52	34	26	RESET_b	RESET_b	RESET_b							
53	35	27	PTB0/ LLWU_P5	ADCB_CH2	ADCB_CH2	PTB0/ LLWU_P5	I2C0_SCL	FTM1_CH0			FTM1_QD_PHA	UART0_RX
54	36	28	PTB1	ADCB_CH3	ADCB_CH3	PTB1	I2C0_SDA	FTM1_CH1	FTM0_FLT2	EWM_IN	FTM1_QD_PHB	UART0_TX

100 LQFP	64 LQFP	48 LQFP	Pin Name	Default	ALT0	ALT1	ALT2	ALT3	ALT4	ALT5	ALT6	ALT7
82	55	—	PTC10	ADCB_CH7d	ADCB_CH7d	PTC10		FTM3_CH6				
83	56	—	PTC11/ LLWU_P11	ADCB_CH6e	ADCB_CH6e	PTC11/ LLWU_P11		FTM3_CH7				
84	—	—	PTC12	DISABLED		PTC12			FTM_CLKIN0		FTM3_FLT0	
85	—	—	PTC13	DISABLED		PTC13			FTM_CLKIN1			
86	—	—	PTC14	DISABLED		PTC14		I2C0_SCL				
87	—	—	PTC15	DISABLED		PTC15		I2C0_SDA				
88	—	—	VSS	VSS	VSS							
89	—	—	VDD	VDD	VDD							
90	—	—	PTC16	DISABLED		PTC16	CAN1_RX					
91	—	—	PTC17	DISABLED		PTC17	CAN1_TX					
92	—	—	PTC18	DISABLED		PTC18						
93	57	41	PTD0/ LLWU_P12	DISABLED		PTD0/ LLWU_P12	SPI0_PCS0		FTM3_CH0	FTM0_CH0	FLEXPWMA_ A0	
94	58	42	PTD1	ADCA_CH7f	ADCA_CH7f	PTD1	SPI0_SCK		FTM3_CH1	FTM0_CH1	FLEXPWMA_ B0	
95	59	43	PTD2/ LLWU_P13	DISABLED		PTD2/ LLWU_P13	SPI0_SOUT		FTM3_CH2	FTM0_CH2	FLEXPWMA_ A1	I2C0_SCL
96	60	44	PTD3	DISABLED		PTD3	SPI0_SIN		FTM3_CH3	FTM0_CH3	FLEXPWMA_ B1	I2C0_SDA
97	61	45	PTD4/ LLWU_P14	DISABLED		PTD4/ LLWU_P14	SPI0_PCS1	UART0_ RTS_b	FTM0_CH4	FLEXPWMA_ A2	EWM_IN	SPI0_PCS0
98	62	46	PTD5	ADCA_CH6g	ADCA_CH6g	PTD5	SPI0_PCS2	UART0_ CTS_b/ UART0_ COL_b	FTM0_CH5	FLEXPWMA_ B2	EWM_OUT_b	SPI0_SCK
99	63	47	PTD6/ LLWU_P15	ADCA_CH7g	ADCA_CH7g	PTD6/ LLWU_P15	SPI0_PCS3	UART0_RX	FTM0_CH6	FTM1_CH0	FTM0_FLT0	SPI0_SOUT
100	64	48	PTD7	DISABLED		PTD7		UART0_TX	FTM0_CH7	FTM1_CH1	FTM0_FLT1	SPI0_SIN

5.2 Pinout diagrams

The following diagrams show pinouts for the packages. For each pin, the diagrams show the default function. However, many signals may be multiplexed onto a single pin.

- During normal operation, don't exceed any of the chip's operating requirements.
- If you must exceed an operating requirement at times other than during normal operation (for example, during power sequencing), limit the duration as much as possible.

8.8 Definition: Typical value

A *typical value* is a specified value for a technical characteristic that:

- Lies within the range of values specified by the operating behavior
- Given the typical manufacturing process, is representative of that characteristic during operation when you meet the typical-value conditions or other specified conditions

Typical values are provided as design guidelines and are neither tested nor guaranteed.

8.8.1 Example 1

This is an example of an operating behavior that includes a typical value:

Symbol	Description	Min.	Typ.	Max.	Unit
I_{WP}	Digital I/O weak pullup/pulldown current	10	70	130	µA

8.8.2 Example 2

This is an example of a chart that shows typical values for various voltage and temperature conditions:

Table 43. Revision history (continued)

Rev. No.	Date	Substantial Changes
		• Obtaining package dimensions • Pinout • In table "Power consumption operating behaviors", removed the text "Maximum core fequency of 150 Mhz" from note for I_{DDA}. • In table "Typical device clock specifications", removed information about High Speed run mode.

2	8/2015	• Updated instances of operating frequency from 150 MHz to 168 Mhz
		• Changed document number from "KV4XP100M150" to "KV4XP100M168" due to the change in operating frequency
		• Part numbers ending with "15" changed to ending with "16"
		• Removed instances of MKV45, MKV43, and MKV40 part numbers
		• Updated MKV41 part numbers to MKV42
		• Added part numbers MKV44F256VLL16 and MKV44F256VLH16
		• Updated table "Orderable part numbers summary"
		• In table Recommended Operating Conditions :
		  • Updated minimum digital supply voltage to 1.71 V
		  • Added footnote numbers 2 and 3
		  • Removed rows for I_{OH}, I_{OL}, N_F, T_R, and t_{FLRET}
		• Updated table Voltage and current operating behaviors
		• Updated table Power mode transition operating behaviors
		• Updated table Power consumption operating behaviors
		• Updated table EMC radiated emissions operating behaviors
		• Updated table Typical device clock specifications
		• Updated table Thermal attributes
		• Updated the PLL section of table MCG specifications
		• Updated t_{ersall} value in table Flash timing specifications — commands
		• Added note to section 12-bit cyclic Analog-to-Digital Converter (ADC) parameters
		• Updated $I_{DDA\_DACL\ P}$ and $I_{DDA\_DACH\ P}$ values in table 12-bit DAC operating behaviors
		• Updated the pinouts
		• Added section Enhanced NanoEdge PWM characteristics

3	06/2016	• Changed occurences of Freescale to NXP • In the features list, added a section for "Kinetis Motor Suite" • Added section Kinetis Motor Suite (KMS) • In table 12-bit ADC electrical specifications, changed typical value of ENOB from 9.5 to 9.1

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